#### **AUTOMOTIVE GRADE**

PD-96290A

# International Rectifier

# AUIRF2804 AUIRF2804S AUIRF2804L

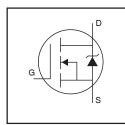
HEXFET® Power MOSFET

#### **Features**

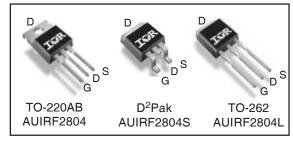
- Advanced Process Technology
- Ultra Low On-Resistance
- 175°C Operating Temperature
- Fast Switching
- Repetitive Avalanche Allowed up to Tjmax
- · Lead-Free, RoHS Compliant
- Automotive Qualified \*

#### **Description**

Specifically designed for Automotive applications, this HEXFET® Power MOSFET utilizes the latest processing techniques to achieve extremely low onresistance per silicon area. Additional features of this design are a 175°C junction operating temperature, fast switching speed and improved repetitive avalanche rating. These features combine to make this design an extremely efficient and reliable device for use in Automotive applications and a wide variety of other applications.



V <sub>(BR)DSS</sub>	40V
R <sub>DS(on)</sub> typ.	1.5mΩ ®
	2.0mΩ ®
I <sub>D (Silicon Limited)</sub>	270A ①
I <sub>D</sub> (Package Limited)	195A



G	D	S
Gate	Drain	Source

## **Absolute Maximum Ratings**

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only; and functional operation of the device at these or any other condition beyond those indicated in the specifications is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. The thermal resistance and power dissipation ratings are measured under board mounted and still air conditions. Ambient temperature  $(T_A)$  is 25°C, unless otherwise specified.

	Parameter	Max.	Units
I <sub>D</sub> @ T <sub>C</sub> = 25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V (Silicon Limited)	270①	
I <sub>D</sub> @ T <sub>C</sub> = 100°C	Continuous Drain Current, V <sub>GS</sub> @ 10V (Silicon Limited)	190	
I <sub>D</sub> @ T <sub>C</sub> = 25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V (Package Limited)	195	A
I <sub>DM</sub>	Pulsed Drain Current ②	1080	
P <sub>D</sub> @T <sub>C</sub> = 25°C	Maximum Power Dissipation	300	W
	Linear Derating Factor	2.0	W/°C
$V_{GS}$	Gate-to-Source Voltage	± 20	V
E <sub>AS</sub>	Single Pulse Avalanche Energy (Thermally Limited) 3	540	
E <sub>AS</sub> (tested)	Single Pulse Avalanche Energy Tested Value ®	1160	mJ
I <sub>AR</sub>	Avalanche Current ②	See Fig.12a,12b,15,16	Α
E <sub>AR</sub>	Repetitive Avalanche Energy ②		mJ
TJ	Operating Junction and	-55 to + 175	
T <sub>STG</sub>	Storage Temperature Range		°C
	Soldering Temperature, for 10 seconds	300 (1.6mm from case)	
	Mounting torque, 6-32 or M3 screw	10 lbf•in (1.1N•m)	

#### Thermal Resistance

Thornia Hooletanee							
	Parameter	Тур.	Max.	Units			
R <sub>eJC</sub>	Junction-to-Case ®		0.50				
R <sub>θCS</sub>	Case-to-Sink, Flat, Greased Surface	0.50		°C/W			
$R_{\theta JA}$	Junction-to-Ambient		62	- C/VV			
ReJA	Junction-to-Ambient (PCB Mount, steady state) ②		40	]			

HEXFET® is a registered trademark of International Rectifier.

\*Qualification standards can be found at http://www.irf.com/ www.irf.com/

### Static Electrical Characteristics @ T<sub>J</sub> = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions
V <sub>(BR)DSS</sub>	Drain-to-Source Breakdown Voltage	40			V	$V_{GS} = 0V, I_D = 250\mu A$
$\Delta BV_{DSS}/\Delta T_{J}$	Breakdown Voltage Temp. Coefficient		0.031		V/°C	Reference to 25°C, I <sub>D</sub> = 1mA
R <sub>DS(on)</sub> SMD	Static Drain-to-Source On-Resistance		1.5	2.0		V <sub>GS</sub> = 10V, I <sub>D</sub> = 75A ④⑩
R <sub>DS(on)</sub> TO-220	Static Drain-to-Source On-Resistance		1.8	2.3	mΩ	V <sub>GS</sub> = 10V, I <sub>D</sub> = 75A ⊕®
V <sub>GS(th)</sub>	Gate Threshold Voltage	2.0		4.0	V	$V_{DS} = V_{GS}, \ I_D = 250 \mu A$
gfs	Forward Transconductance	130			S	V <sub>DS</sub> = 10V, I <sub>D</sub> = 75A <sup>®</sup>
I <sub>DSS</sub>	Drain-to-Source Leakage Current			20		$V_{DS} = 40V, V_{GS} = 0V$
				250	μA	$V_{DS} = 40V, V_{GS} = 0V, T_{J} = 125^{\circ}C$
I <sub>GSS</sub>	Gate-to-Source Forward Leakage			200		V <sub>GS</sub> = 20V
	Gate-to-Source Reverse Leakage			-200	nA	V <sub>GS</sub> = -20V

## Dynamic Electrical Characteristics @ T<sub>J</sub> = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions
$Q_g$	Total Gate Charge		160	240		I <sub>D</sub> = 75A ®
$Q_{gs}$	Gate-to-Source Charge		41	62	nC	$V_{DS} = 32V$
$Q_{gd}$	Gate-to-Drain ("Miller") Charge		66	99		V <sub>GS</sub> = 10V ④
t <sub>d(on)</sub>	Turn-On Delay Time		13			$V_{DD} = 20V$
t <sub>r</sub>	Rise Time		120		l	I <sub>D</sub> = 75A ®
t <sub>d(off)</sub>	Turn-Off Delay Time		130		ns	$R_G = 2.5\Omega$
t <sub>f</sub>	Fall Time		130			V <sub>GS</sub> = 10V ④
L <sub>D</sub>	Internal Drain Inductance		4.5			Between lead,
			4.5		nH	6mm (0.25in.)
Ls	Internal Source Inductance		7.5		] ""	from package
			7.5			and center of die contact
Ciss	Input Capacitance		6450			$V_{GS} = 0V$
Coss	Output Capacitance		1690			$V_{DS} = 25V$
C <sub>rss</sub>	Reverse Transfer Capacitance		840		]	f = 1.0MHz, See Fig. 5
Coss	Output Capacitance		5350		pF	$V_{GS} = 0V$ , $V_{DS} = 1.0V$ , $f = 1.0MHz$
Coss	Output Capacitance		1520			$V_{GS} = 0V, V_{DS} = 32V, f = 1.0MHz$
C <sub>oss</sub> eff.	Effective Output Capacitance		2210		1	$V_{GS} = 0V, V_{DS} = 0V \text{ to } 32V^{\text{(5)}}$

#### **Diode Characteristics**

	Parameter	Min.	Тур.	Max.	Units	Conditions		
Is	Continuous Source Current			270 ①		MOSFET symbol		
	(Body Diode)			270 ©		showing the		
I <sub>SM</sub>	Pulsed Source Current			1080	1080	1080	1080 A	integral reverse
	(Body Diode) ①			1000		p-n junction diode.		
$V_{\text{SD}}$	Diode Forward Voltage			1.3	V	$T_J = 25^{\circ}C, I_S = 75A^{\circ}$ , $V_{GS} = 0V^{\circ}$		
t <sub>rr</sub>	Reverse Recovery Time		56	84	ns	$T_J = 25^{\circ}C, I_F = 75A^{\circ}$ , $V_{DD} = 20V$		
Q <sub>rr</sub>	Reverse Recovery Charge		67	100	nC	di/dt = 100A/µs ④		
ton	Forward Turn-On Time	Intrinsictum-ontimeis negligible (turn-onis abminatedby LS+LD)						

#### Notes:

- ① Calculated continuous current based on maximum allowable junction temperature. Package limitation current is 195A. Note that current limitations arising from heating of the device leads may occur with some lead mounting arrangements.(Refer to AN-1140) http://www.irf.com/technical-info/appnotes/an-1140.pdf
- ② Repetitive rating; pulse width limited by max. junction temperature. (See fig. 11).
- 3 Limited by  $T_{Jmax}$ , starting  $T_J$  = 25°C, L=0.24mH,  $R_G$  = 25 $\Omega$ ,  $I_{AS}$  = 75A,  $V_{GS}$  =10V.

- 4 Pulse width  $\leq$  1.0ms; duty cycle  $\leq$  2%
- $^{\circ}$  C<sub>oss</sub> eff. is a fixed capacitance that gives the same charging time as C<sub>oss</sub> while V<sub>DS</sub> is rising from 0 to 80% V<sub>DSs</sub>.
- $\ \, \ \,$  This value determined from sample failure population , starting T  $_J$  = 25°C, L=0.24mH, R  $_G$  = 25 $\Omega$ , I  $_{AS}$  = 75A, V  $_{GS}$  =10V.
- This is applied to D<sup>2</sup>Pak, when mounted on 1" square PCB (FR-4 or G-10 Material). For recommended footprint and soldering techniques refer to application note #AN-994.
- Max R<sub>DS(on)</sub> for D<sup>2</sup>Pak and TO-262 (SMD) devices.
- 9 TO-220 device will have an Rth value of 0.45°C/W...
- M All AC and DC test condition based on old Package limitation current = 75A.

# Qualification Information<sup>†</sup>

		Automotive (per AEC-Q101) <sup>††</sup>			
Qualification Level		Comments: This part number(s) passed Automotive qualification. IR's Industrial and Consumer qualificati level is granted by extension of the higher Automotiv level.			
		D2 PAK	MSL1		
Moisture Sensi	Moisture Sensitivity Level		N/A		
		TO-262	IV/A		
	   Machine Model	Class M4			
	Macrille Model	AEC-Q101-002			
FOD	Ll Dady Madal	Class H3A			
ESD	Human Body Model	AEC-Q101-001			
			Class C5		
	Charged Device Model		AEC-Q101-005		
RoHS Compliant			Yes		

<sup>†</sup> Qualification standards can be found at International Rectifier's web site: http://www.irf.com/

<sup>††</sup> Exceptions to AEC-Q101 requirements are noted in the qualification report.

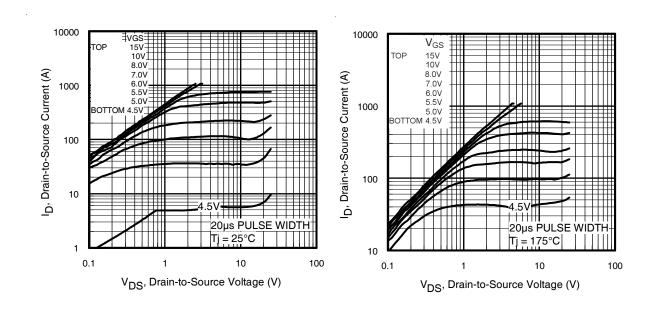


Fig 1. Typical Output Characteristics

Fig 2. Typical Output Characteristics

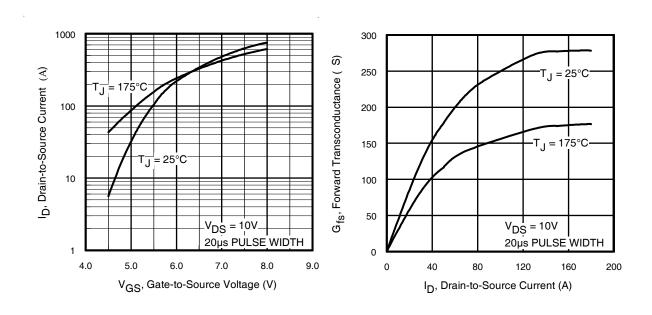
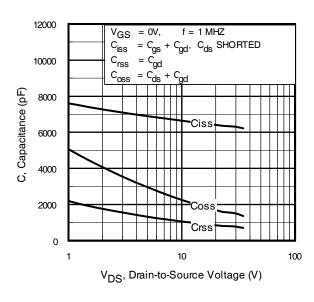
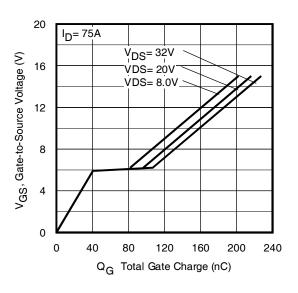


Fig 3. Typical Transfer Characteristics

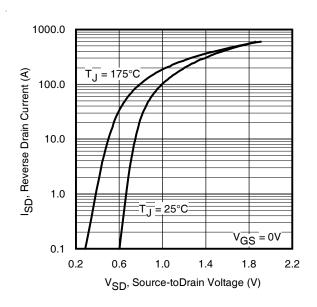
Fig 4. Typical Forward Transconductance vs. Drain Current





**Fig 5.** Typical Capacitance vs. Drain-to-Source Voltage

**Fig 6.** Typical Gate Charge vs. Gate-to-Source Voltage





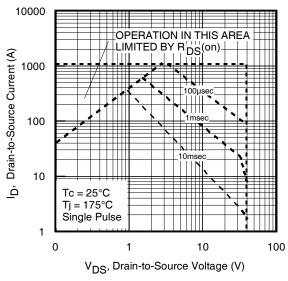
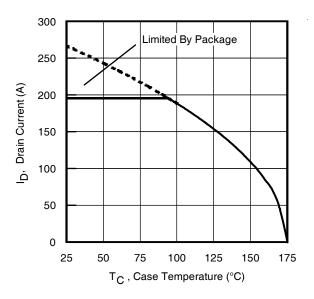
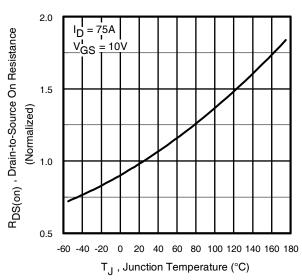


Fig 8. Maximum Safe Operating Area





**Fig 9.** Maximum Drain Current vs. Case Temperature

**Fig 10.** Normalized On-Resistance vs. Temperature

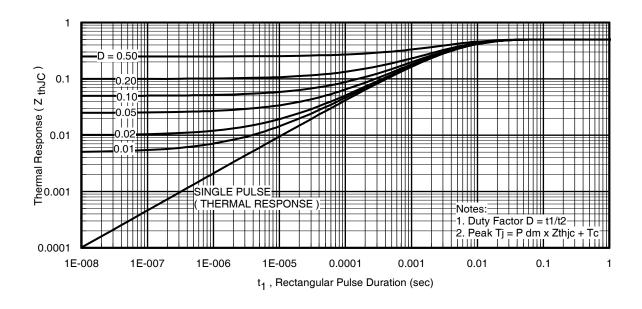


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

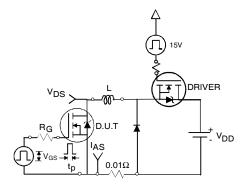


Fig 12a. Unclamped Inductive Test Circuit

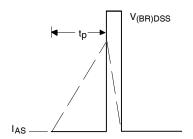


Fig 12b. Unclamped Inductive Waveforms

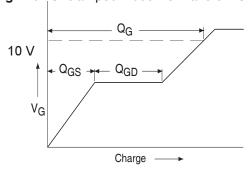
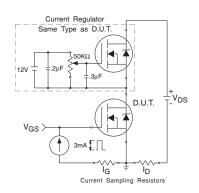
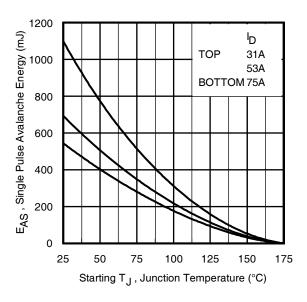


Fig 13a. Basic Gate Charge Waveform



**Fig 13b.** Gate Charge Test Circuit www.irf.com



**Fig 12c.** Maximum Avalanche Energy vs. Drain Current

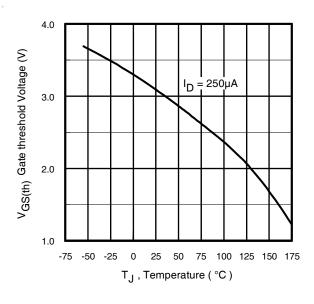


Fig 14. Threshold Voltage vs. Temperature

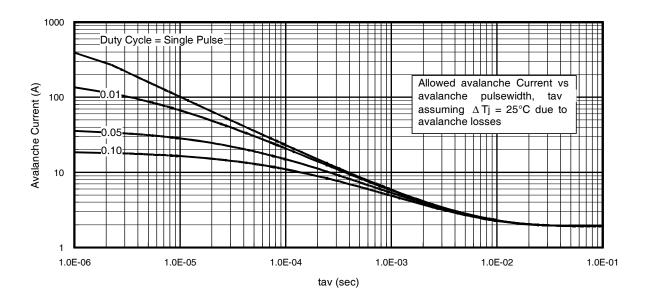
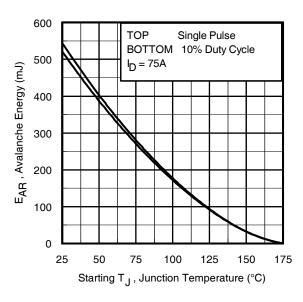


Fig 15. Typical Avalanche Current Vs.Pulsewidth



**Fig 16.** Maximum Avalanche Energy vs. Temperature

# Notes on Repetitive Avalanche Curves , Figures 15, 16: (For further info, see AN-1005 at www.irf.com)

- Avalanche failures assumption:
   Purely a thermal phenomenon and failure occurs at a temperature far in excess of T<sub>jmax</sub>. This is validated for every part type.
- Safe operation in Avalanche is allowed as long asT<sub>jmax</sub> is not exceeded.
- 3. Equation below based on circuit and waveforms shown in Figures 12a, 12b.
- 4. P<sub>D (ave)</sub> = Average power dissipation per single avalanche pulse.
- 5. BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
- 6. I<sub>av</sub> = Allowable avalanche current.
- 7.  $\Delta T$  = Allowable rise in junction temperature, not to exceed  $T_{jmax}$  (assumed as 25°C in Figure 15, 16).  $t_{av}$  = Average time in avalanche.

 $D = Duty cycle in avalanche = t_{av} \cdot f$ 

 $Z_{th,JC}(D, t_{av})$  = Transient thermal resistance, see figure 11)

$$\begin{split} P_{D\;(ave)} &= 1/2\;(\;1.3 \cdot BV \cdot I_{aV}) = \triangle T/\;Z_{thJC} \\ I_{av} &= 2\triangle T/\;[1.3 \cdot BV \cdot Z_{th}] \\ E_{AS\;(AR)} &= P_{D\;(ave)} \cdot t_{av} \end{split}$$

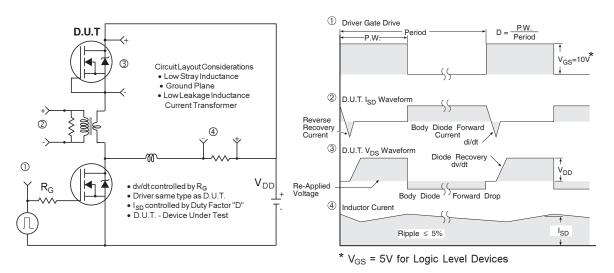


Fig 17. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs

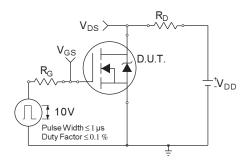


Fig 18a. Switching Time Test Circuit

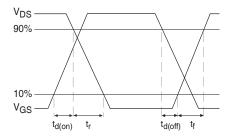
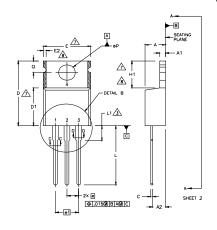
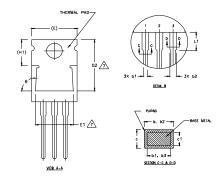


Fig 18b. Switching Time Waveforms

# TO-220AB Package Outline

Dimensions are shown in millimeters (inches)





- DIMENSIONING AND TOLERANCING PER ASME Y14.5 M- 1994,
  DIMENSIONING AND SHOWN IN INCHES [MILLIMETERS].
  LEAD DIMENSION AND FINISH UNCONTROLLED IN L1.
  DIMENSION D & E DO NOT INCLUDE MOLD FLASH, MOLD FLASH
  SHALL NOT EXCEED .006" (0.127) PER SIDE. THESE DIMENSIONS ARE
  MEASURED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.
  DIMENSION B & c1 APPLY TO BASE METAL ONLY.
  CONTROLLING DIMENSION: INCHES.
  THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSIONS E,H1,D2 & E1
  DIMENSION EX H1 DEFINE A ZONE WHERE STAMPING
  AND SINGULATION IRREGULARTIES ARE ALLOWED.

4.82

1,40 2,92 1,01 0.96

1,77 1,73

0.61

16,51

9,02

12.88

6,55

14.73 6.35

4.08

DIMENSIONS

MIN.

.140

,020 ,080 ,015 ,015

,045 ,045 ,014

,560 ,330

,480 ,380

MILLIMETERS MIN.

3.56

0.51 2.04 0.38

1,15 1,15

0.36

8,38

9.66

5,85

3.54

2,54

A2

ь2 ь3

D D1

E E1

e e1 H1

HEXFET

IGBTs, CoPACK

1.- CATE
2.- COLLECTOR
3.- EMITTER

NOTES

4,7

7,8

.190

,055 ,115 ,040

.038

.070 .068 .024

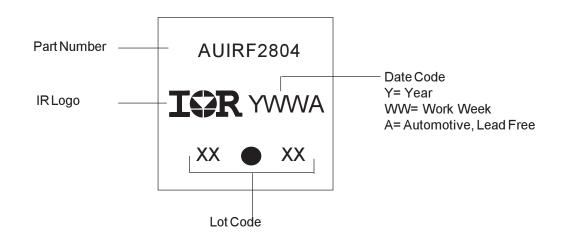
.355

.507

.270

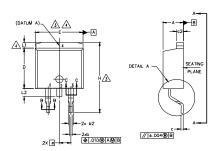
.580 .250

TO-220AB Part Marking Information



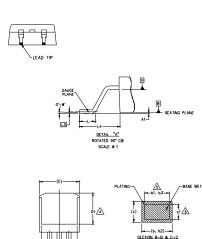
Note: For the most current drawing please refer to IR website at http://www.irf.com/package/ 10 www.irf.com

# $D^2 Pak \ \ Package \ \ Outline \ \ \ (\hbox{\tiny Dimensions are shown in millimeters (inches)})$



#### MOTES

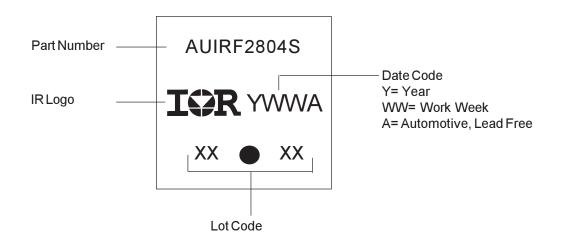
- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
- 2. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].
- 3. DIMENSION D & E DO NOT INCLUDE MOLD FLASH, MOLD FLASH SHALL NOT EXCEED 0.127 [.005"] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY AT DATUM H.
- 4. THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSION E, L1, D1 & E1.
- 5. DIMENSION 61 AND c1 APPLY TO BASE METAL ONLY.
- 6. DATUM A & B TO BE DETERMINED AT DATUM PLANE H.
- 7 CONTROLLING DIMENSION: INCH
- 8. OUTLINE CONFORMS TO JEDEC OUTLINE TO-263AB.



5 Y		Ŋ			
M B O L	MILLIM	ETERS	INC	HES	O T E S
L	MIN.	MAX.	MIN.	MAX.	Š
Α	4.06	4,83	.160	.190	
A1	0.00	0.254	.000	.010	
ь	0.51	0.99	.020	.039	
ь1	0,51	0.89	.020	.035	5
b2	1,14	1.78	.045	.070	
b3	1,14	1.73	.045	.068	5
С	0.38	0.74	.015	.029	
c1	0.38	0.58	.015	.023	5
c2	1,14	1.65	.045	.065	
D	8.38	9.65	.330	.380	3
D1	6.86	-	.270		4
E	9.65	10,67	.380	.420	3,4
E1	6.22	-	.245		4
e	2.54	BSC	.100	BSC	
н	14,61	15,88	.575	.625	
L	1,78	2.79	.070	.110	
L1	-	1.65	-	.066	4
L2	1,27	1.78	-	.070	
L3	0.25	BSC	.010	.010 BSC	
L4	4.78	5.28	.188	.208	

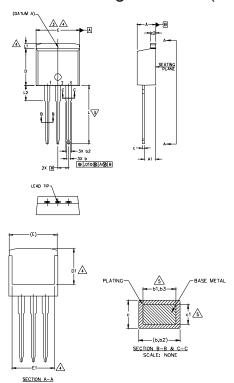
LEAD ASSIGNMENTS
HEXFET 1.— GATE 2. 4.— DRAIN 3.— SOURCE
IGRTS, COPACK  1.— GATE  2. 4.— COLLECTOR  3.— EMITTER
DIODES  1.— ANODE *  2. 4.— CATHODE  3.— ANODE
* PART DEPENDEN

# D<sup>2</sup>Pak Part Marking Information



Note: For the most current drawing please refer to IR website at <a href="http://www.irf.com/package/">http://www.irf.com/package/</a> www.irf.com

# TO-262 Package Outline ( Dimensions are shown in millimeters (inches))



- 1. DIMENSIONING AND TOLERANCING PER ASME Y14,5M-1994
- 2. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].
- 3. DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED 0.127 [.005"] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY.
- 4. THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSION E, L1, D1 & E1.
- 5. DIMENSION 61 AND c1 APPLY TO BASE METAL ONLY.
- 6. CONTROLLING DIMENSION: INCH.
- 7.- OUTLINE CONFORM TO JEDEC TO-262 EXCEPT A1(max.), b(min.) AND D1(min.) WHERE DIMENSIONS DERIVED THE ACTUAL PACKAGE OUTLINE.

S Y M B			N		
B	MILLIM	MILLIMETERS		HES	N O T E S
Ľ	MIN.	MAX.	MIN.	MAX.	S
Α	4.06	4.83	.160	.190	
A1	2.03	3.02	.080	.119	
b	0.51	0.99	.020	.039	
ь1	0.51	0,89	,020	.035	5
b2	1,14	1,78	.045	.070	
b3	1,14	1,73	.045	.068	5
c	0.38	0.74	.015	.029	
c1	0.38	0.58	.015	.023	5
c2	1,14	1.65	.045	.065	
D	8.38	9.65	.330	.380	3
D1	6,86	-	,270	-	4
Ε	9.65	10.67	.380	.420	3,4
E1	6.22	-	.245		4
e	2.54	BSC	,100 BSC		
L	13,46	14,10	.530	.555	
L1	-	1.65	-	.065	4
L2	3,56	3,71	.140	.146	

#### LEAD ASSIGNMENTS

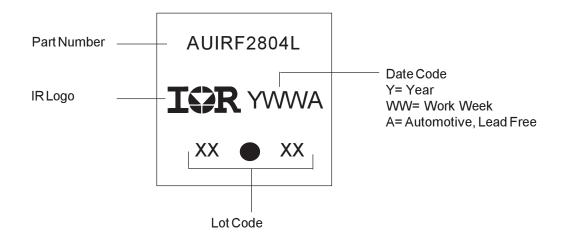
#### **HEXFET**

- 1.- GATE 2.- DRAIN 3.- SOURCE 4.- DRAIN

#### IGBTs, CoPACK

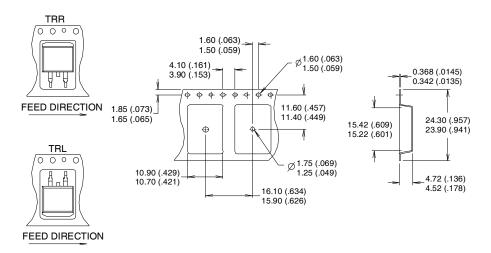
- 1.- GATE
  2.- COLLECTOR
  3.- EMITTER
  4.- COLLECTOR

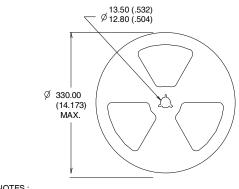
TO-262 Part Marking Information

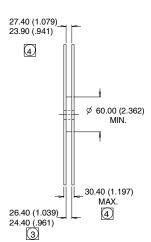


Note: For the most current drawing please refer to IR website at http://www.irf.com/package/

# D<sup>2</sup>Pak Tape & Reel Infomation







#### NOTES:

- COMFORMS TO EIA-418.
   CONTROLLING DIMENSION: MILLIMETER.
   DIMENSION MEASURED @ HUB.
- INCLUDES FLANGE DISTORTION @ OUTER EDGE.

# **Ordering Information**

Base part	Package Type	Standard Pack		Complete Part Number
		Form	Quantity	
AUIRF2804	TO-220	Tube	50	AUIRF2804
AUIRF2804L	TO-262	Tube	50	AUIRF2804L
AUIRF2804S	D2Pak	Tube	50	AUIRF2804S
		Tape and Reel Left	800	AUIRF2804STRL
		Tape and Reel Right	800	AUIRF2804STRR

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# AMEYA360 Components Supply Platform

# **Authorized Distribution Brand:**

























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